

<b>Notice of References Cited</b>	Application/Control No. 10/691,891	Applicant(s)/Patent Under Reexamination WANG ET AL.	
	Examiner Marcus Charles	Art Unit 3682	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,892,354	06-1959	AMONSEN GEORGE H	474/46
*	B	US-4,781,660	11-1988	Amataka et al.	474/174
*	C	US-6,068,564	05-2000	Takahara, Hideaki	474/12
*	D	US-6,106,689	08-2000	Matsuyama, Jinsho	205/333
*	E	US-6,254,503	07-2001	Chiba et al.	474/8
*	F	US-6,078,143	06-2000	Nerone, Louis R.	315/209R
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02-30437 A	01-1990	Japan	Taniguchi et al.	28/892.2
	O	JP (59-205064) A	11-1984	Japan	Kimura et al.	254/360
	P	JP (62-30900) A	02-1987	Japan	Hasegawa et al.	205/668
	Q	JP (2001-343056) A	12-2001	Japan	Nakajima	F16H 9/18
	R	JP (2002-213580)	07-2002	Japan	Shimura et al.	F16H 55/49
	S	JP (2002-21956) A	01-2002	Japan	Murase et al.	F16H 9/18
	T	JP (2002-70992) A	03-2002	Japan	Nakajima et al.	F16H 9/12

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.